

Search Notes

Application/Control No.

10/771,083

Examiner

Toan M. Le

Applicant(s)/Patent under
Reexamination

HOFMEISTER ET AL.

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	120	5/24/2005	TL
372	38.1	5/12/2005	TL
372	50	5/12/2005	TL
257	688	5/20/2005	TL
385	92	5/20/2005	TL
385	93	5/20/2005	TL
372	38.02	5/23/2005	TL
Above	Updated	12/22/2005	TL
Above	Updated	7/21/2006	TL
398	135	7/21/2006	TL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Electrostatic Discharge Damage, Photodiode, Laser	5/12/2005	TL
Laser Diode, Switch, Transceiver, Pins	5/12/2005	TL
Transceiver Module, Laser Diode	5/12/2005	TL
VCSEL, Laser Drive, Laser Diode, Transceiver	5/23/2005	TL
702/120; 372/38.1, 38.02; 257/688; 398/135 (Laser Diode)	7/21/2006	TL
East-See Search History Printout	7/21/2006	TL
IEEE Xplore, Web	7/21/2006	TL